



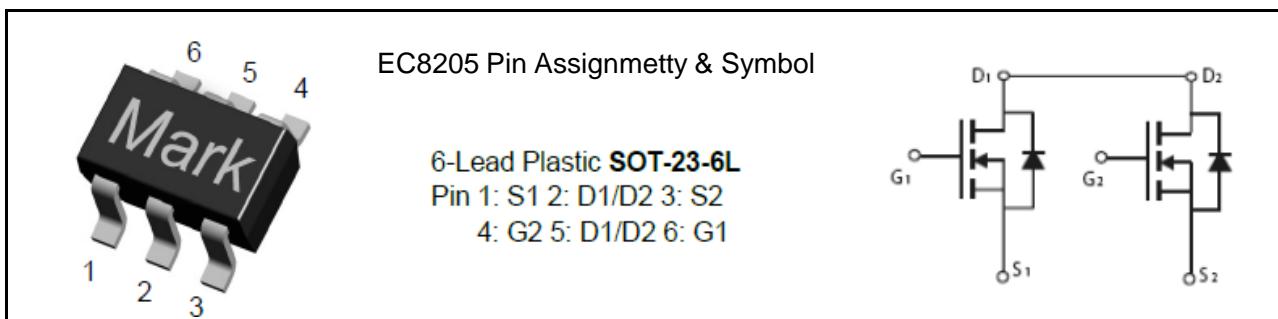
Dual N-Channel High Density Trench MOSFET (20V, 6A)

PRODUCT SUMMARY

V_{DSS}	I_D	$R_{DS(on)}$ (mΩ) Typ.
20V	6.0A	20@ VGS = 4.5V, ID=6A
		23@ VGS = 4.0V, ID=6A
		26@ VGS = 2.5V, ID=5.2A

Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Surface mount Package
- Lead (Pb) -free and halogen-free



Absolute Maximum Ratings ($T_A=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-Source Voltage	± 12	V
I_D	Drain Current (Continuous)	6	A
I_{DM}	Drain Current (Pulsed) ^a	20	A
P_D	Total Power Dissipation @ $T_A=25^\circ\text{C}$	1.25	W
I_S	Maximum Diode Forward Current	1.7	A
T_j, T_{stg}	Operating Junction and Storage Temperature Range	-55 to +150	°C
R_{QJA}	Thermal Resistance Junction to Ambient (PCB mounted) ^b	100	°C/W

a: Repetitive Rating: Pulse width limited by the maximum junction temperature.

b: 1-in² 2oz Cu PCB board



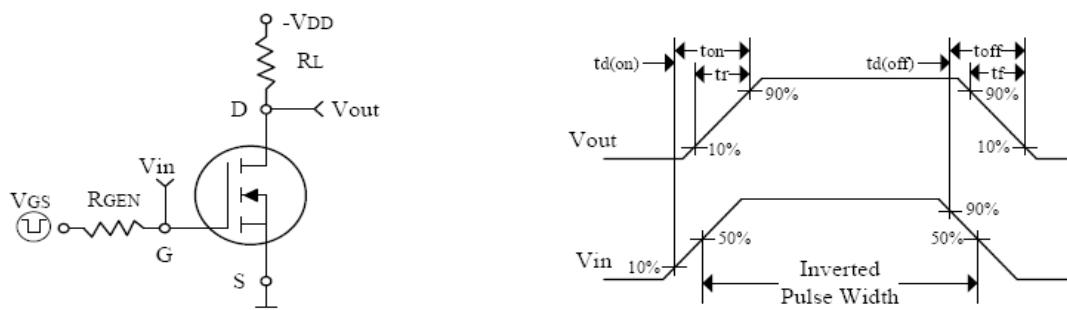
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Electrical Characteristics ($T_A=25^\circ\text{C}$, unless otherwise noted)

Symbol	Characteristic	Test Conditions	Min.	Typ.	Max.	Unit
• Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	20	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 12\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 10	μA
• On Characteristics						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	0.6	0.65	1.2	V
$R_{\text{DS(on)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=6\text{A}$	-	20	24	$\text{m}\Omega$
		$V_{\text{GS}}=3\text{V}, I_{\text{D}}=5.2\text{A}$		23	27	
		$V_{\text{GS}}=2.5\text{V}, I_{\text{D}}=5.2\text{A}$	-	26	28	
• Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=6\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	559	-	PF
C_{oss}	Output Capacitance		-	148	-	
C_{rss}	Reverse Transfer Capacitance		-	127	-	
• Switching Characteristics						
Q_g	Total Gate Charge	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=6\text{A}, V_{\text{GS}}=4.5\text{V}$	-	5	-	nC
Q_{gs}	Gate-Source Charge		-	0.9	-	
Q_{gd}	Gate-Drain Charge		-	1.4	-	
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=10\text{V}, R_L=1.2\Omega, I_{\text{D}}=1\text{A}, \text{VGEN}=10\text{V}, RG=6\Omega$	-	10.2	-	nS
t_r	Turn-on Rise Time		-	7	-	
$t_{\text{d(off)}}$	Turn-off Delay Time		-	33	-	
t_f	Turn-off Fall Time		-	6.8	-	
• Drain-Source Diode Characteristics						
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=1.7\text{A}$	-	-	1.2	V

Note: Pulse Test: Pulse Width $\leq 300\text{us}$, Duty Cycle $\leq 2\%$



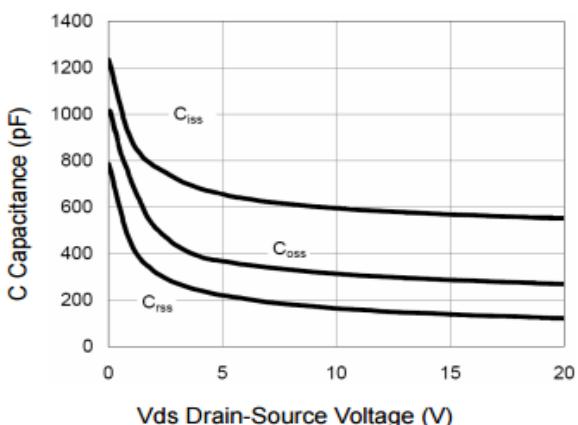
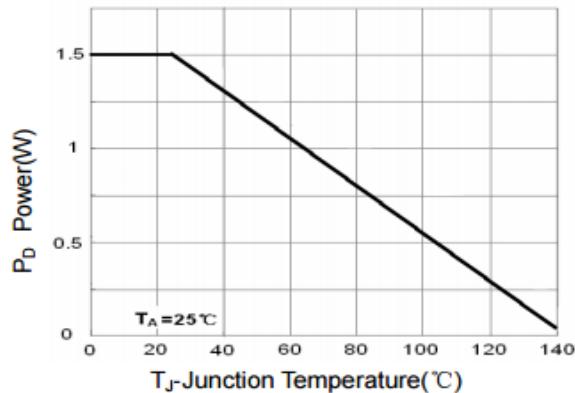
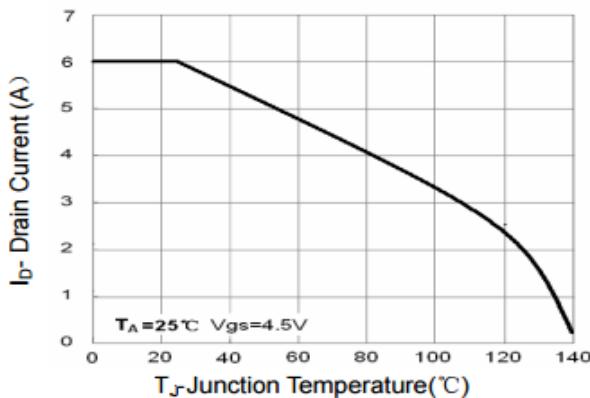
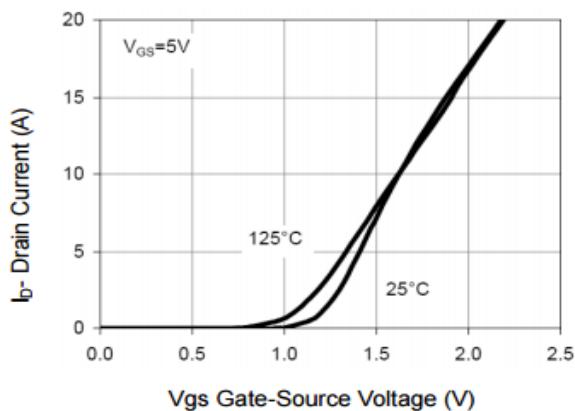
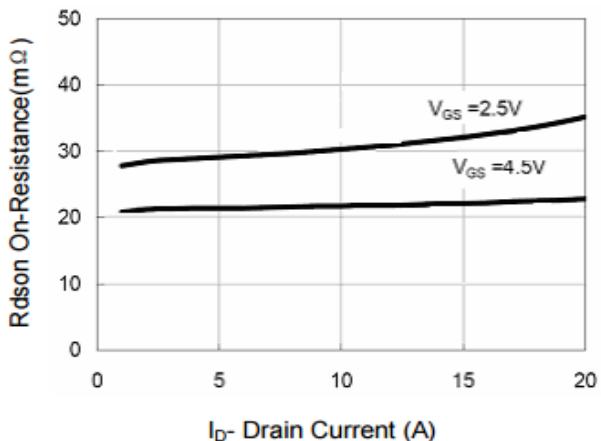
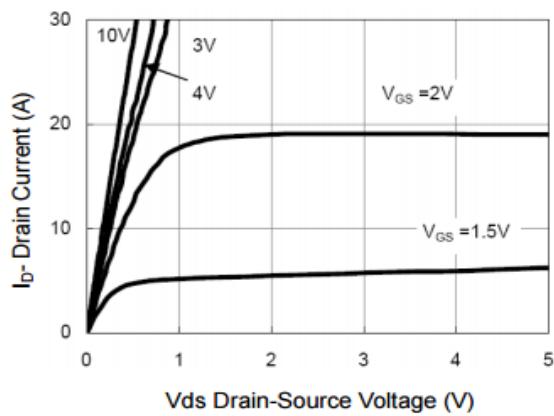
Switching Test Circuit and Switching Waveforms

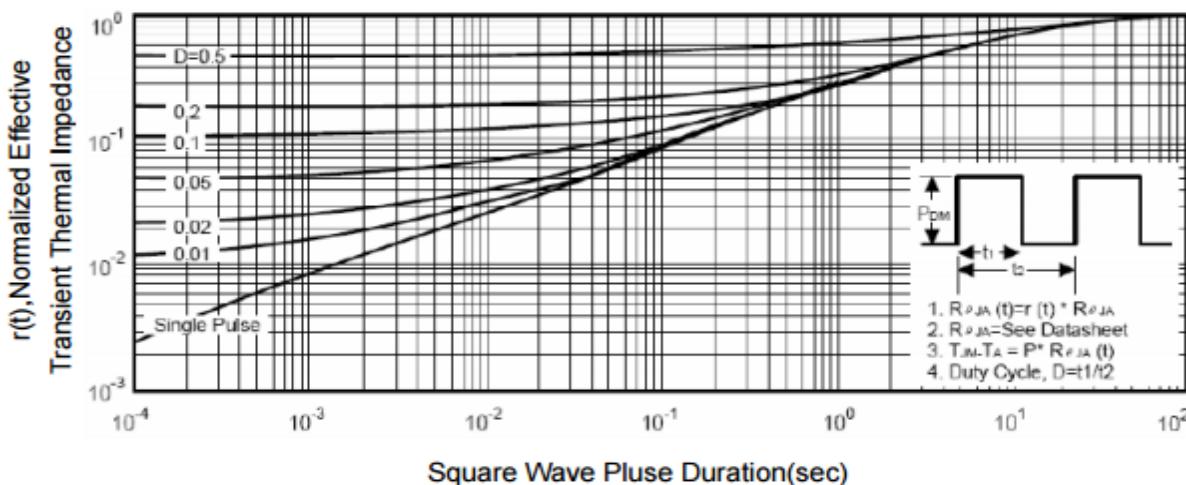
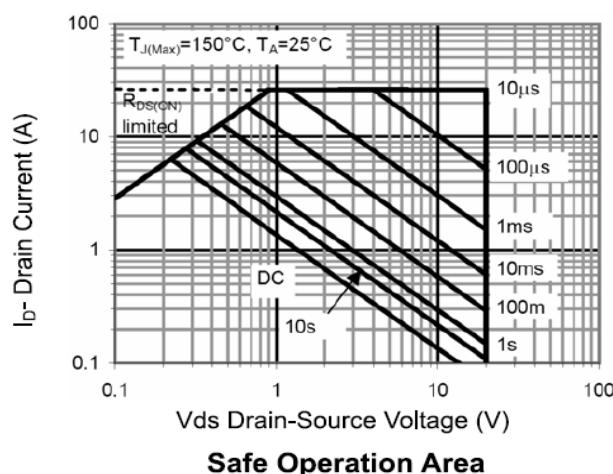
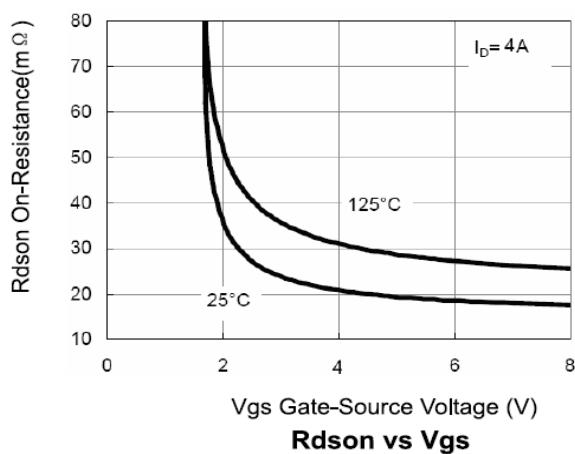
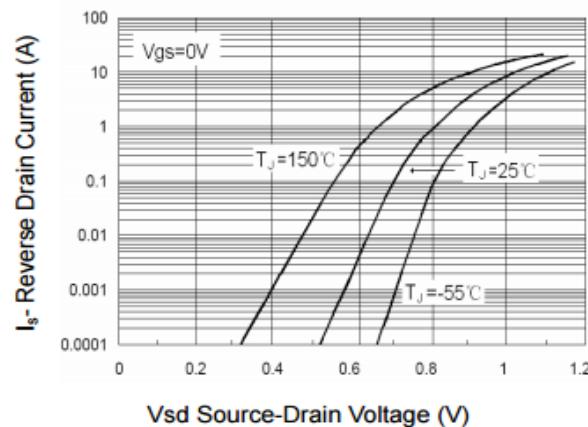
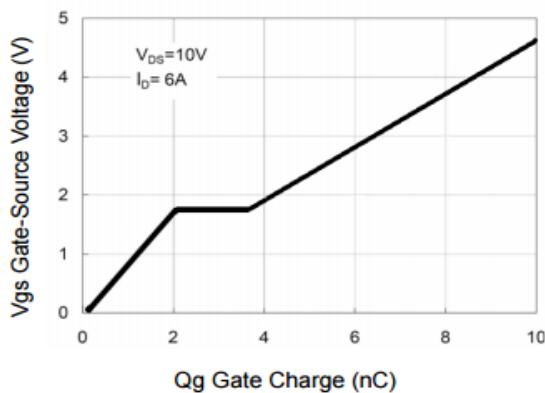


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Typical Characteristics Curves (Ta=25°C, unless otherwise note)



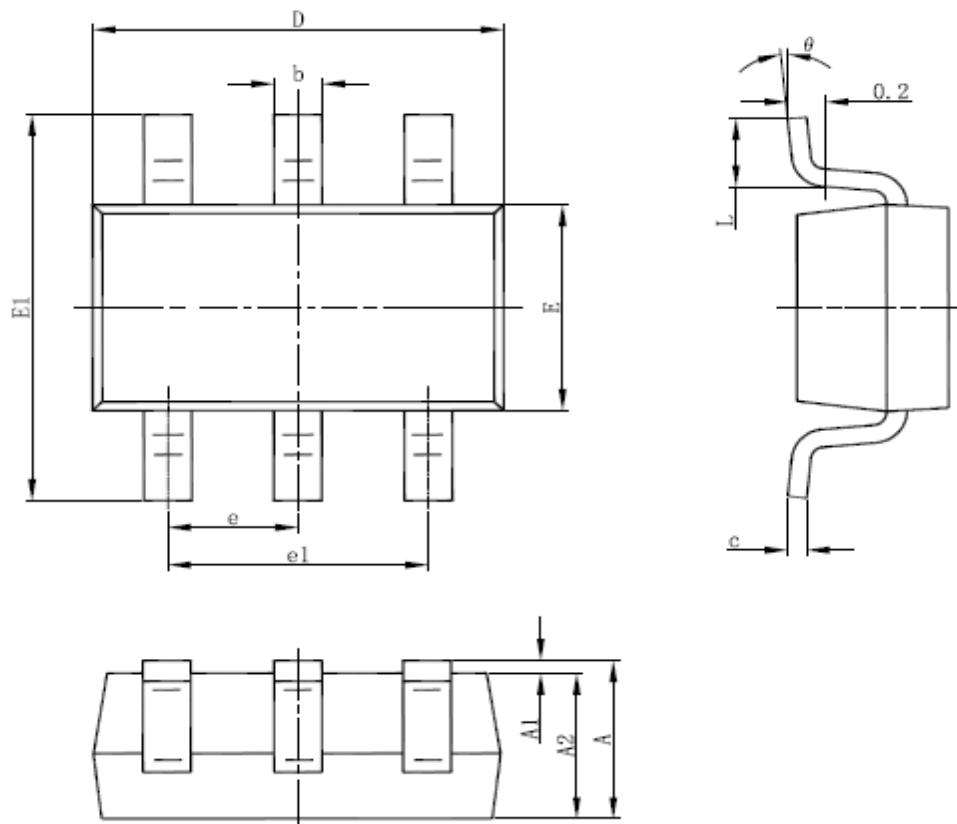




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SOT23-6L PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.650	2.950	0.104	0.116
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°